



# Calibration Certificate of DASY

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Sporton (Auden)**

Certificate No: **DAE4-778\_Sep08**

## CALIBRATION CERTIFICATE

Object: **DAE4 - SD 000 D04 BG - SN: 778**

Calibration procedure(s): **QA CAL-06.v12  
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **September 22, 2008**

Condition of the calibrated item: **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	04-Oct-07 (No: 6467)	Oct-08
Keithley Multimeter Type 2001	SN: 0810278	03-Oct-07 (No: 6465)	Oct-08
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	06-Jun-08 (in house check)	In house check: Jun-09

Calibrated by:	Name Andrea Guntli	Function Technician	Signature 
Approved by:	Fin Bornholt	R&D Director	

Issued: September 22, 2008

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## Glossary

**DAE** data acquisition electronics  
**Connector angle** information used in DASY system to align probe sensor X to the robot coordinate system.

## Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
  - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
  - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
  - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
  - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
  - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
  - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
  - **Input resistance:** DAE input resistance at the connector, during internal auto-zeroing and during measurement.
  - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
  - **Power consumption:** Typical value for information. Supply currents in various operating modes.



**DC Voltage Measurement**

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 $\mu$ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.686 $\pm$ 0.1% (k=2)	403.490 $\pm$ 0.1% (k=2)	405.045 $\pm$ 0.1% (k=2)
Low Range	3.99455 $\pm$ 0.7% (k=2)	3.96369 $\pm$ 0.7% (k=2)	3.99417 $\pm$ 0.7% (k=2)

**Connector Angle**

Connector Angle to be used in DASV system	309 $^{\circ}$ $\pm$ 1 $^{\circ}$
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**Appendix**

**1. DC Voltage Linearity**

High Range	Input ( $\mu\text{V}$ )	Reading ( $\mu\text{V}$ )	Error (%)
Channel X + Input	200000	200000.3	0.00
Channel X + Input	20000	20004.24	0.02
Channel X - Input	20000	-20002.46	0.01
Channel Y + Input	200000	200000.4	0.00
Channel Y + Input	20000	20002.60	0.01
Channel Y - Input	20000	-20002.26	0.01
Channel Z + Input	200000	200000.6	0.00
Channel Z + Input	20000	20000.78	0.00
Channel Z - Input	20000	-20005.75	0.03

Low Range	Input ( $\mu\text{V}$ )	Reading ( $\mu\text{V}$ )	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	199.37	-0.31
Channel X - Input	200	-200.28	0.14
Channel Y + Input	2000	2000	0.00
Channel Y + Input	200	199.63	-0.19
Channel Y - Input	200	-200.88	0.44
Channel Z + Input	2000	2000.1	0.00
Channel Z + Input	200	198.60	-0.70
Channel Z - Input	200	-201.07	0.53

**2. Common mode sensitivity**

DASy measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading ( $\mu\text{V}$ )	Low Range Average Reading ( $\mu\text{V}$ )
Channel X	200	-7.46	-6.40
	-200	10.00	6.86
Channel Y	200	-2.73	-2.45
	-200	0.84	0.43
Channel Z	200	-10.91	-10.94
	-200	7.89	8.22

**3. Channel separation**

DASy measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X ( $\mu\text{V}$ )	Channel Y ( $\mu\text{V}$ )	Channel Z ( $\mu\text{V}$ )
Channel X	200	-	3.08	-1.34
Channel Y	200	1.18	-	4.64
Channel Z	200	-1.74	1.44	-



**4. AD-Converter Values with inputs shorted**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16048	16021
Channel Y	16167	15166
Channel Z	16416	15977

**5. Input Offset Measurement**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	-0.13	-0.88	0.92	0.33
Channel Y	-0.88	-2.47	0.72	0.55
Channel Z	-1.16	-2.17	-0.19	0.42

**6. Input Offset Current**

Nominal Input circuitry offset current on all channels: <25fA

**7. Input Resistance**

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	201.1
Channel Y	0.2000	201.0
Channel Z	0.2001	201.7

**8. Low Battery Alarm Voltage** (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

**9. Power Consumption** (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: ET3-1787\_Aug08

CALIBRATION CERTIFICATE

Object: ET3DV6 - SN:1787, Calibration procedure(s): QA CAL-01.v6 and QA CAL-23.v3, Calibration date: August 26, 2008, Condition of the calibrated item: In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Primary Standards, ID #, Cal Date (Certificate No.), Scheduled Calibration. Lists various power meters, sensors, attenuators, and probes with their respective IDs and calibration dates.

Calibrated by: Katja Pokovic, Technical Manager; Approved by: Niels Kuster, Quality Manager. Includes handwritten signatures.

Issued: August 26, 2008

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Accreditation No.: SCS 108

**Glossary:**

TSL	tissue simulating liquid
NORM <sub>x,y,z</sub>	sensitivity in free space
ConvF	sensitivity in TSL / NORM <sub>x,y,z</sub>
DCP	diode compression point
Polarization $\varphi$	$\varphi$ rotation around probe axis
Polarization $\vartheta$	$\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

**Calibration is Performed According to the Following Standards:**

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

**Methods Applied and Interpretation of Parameters:**

- **NORM<sub>x,y,z</sub>:** Assessed for E-field polarization  $\vartheta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). NORM<sub>x,y,z</sub> are only intermediate values, i.e., the uncertainties of NORM<sub>x,y,z</sub> does not effect the E<sup>2</sup>-field uncertainty inside TSL (see below ConvF).
- **NORM(f)<sub>x,y,z</sub> = NORM<sub>x,y,z</sub> \* frequency\_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- **DCP<sub>x,y,z</sub>:** DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- **ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM<sub>x,y,z</sub> \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- **Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- **Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



ET3DV6 SN:1787

August 26, 2008

# Probe ET3DV6

## SN:1787

Manufactured:	May 28, 2003
Last calibrated:	August 28, 2007
Recalibrated:	August 26, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)





ET3DV6 SN:1787

August 26, 2008

DASY - Parameters of Probe: ET3DV6 SN:1787

Sensitivity in Free Space<sup>A</sup>

Diode Compression<sup>B</sup>

NormX	1.63 ± 10.1%	μV/(V/m) <sup>2</sup>	DCP X	90 mV
NormY	1.67 ± 10.1%	μV/(V/m) <sup>2</sup>	DCP Y	93 mV
NormZ	2.18 ± 10.1%	μV/(V/m) <sup>2</sup>	DCP Z	92 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR <sub>ce</sub> [%]	Without Correction Algorithm	11.3	7.5
SAR <sub>ce</sub> [%]	With Correction Algorithm	0.8	0.5

TSL 1750 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR <sub>ce</sub> [%]	Without Correction Algorithm	10.1	6.5
SAR <sub>ce</sub> [%]	With Correction Algorithm	0.8	0.6

Sensor Offset

Probe Tip to Sensor Center 2.7 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Page 8).

<sup>B</sup> Numerical linearization parameter: uncertainty not required.

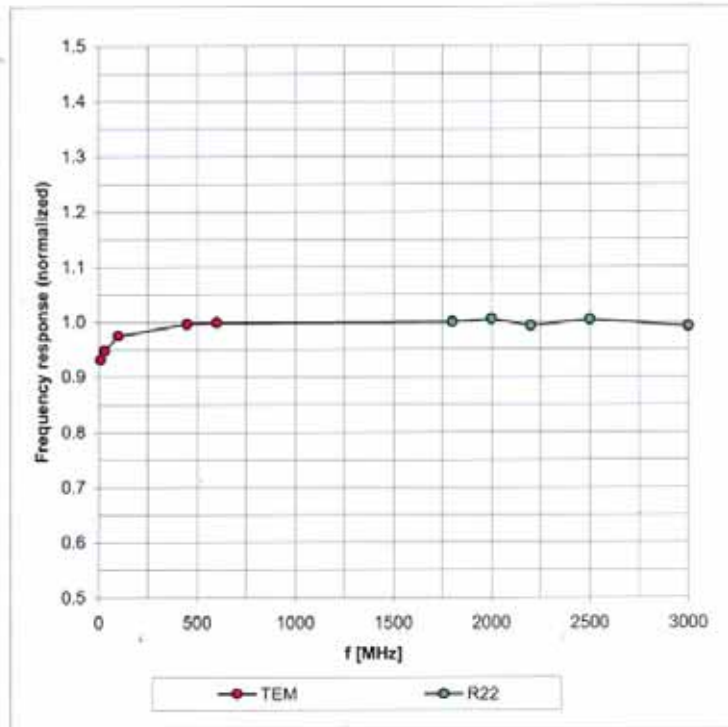


ET3DV6 SN:1787

August 26, 2008

### Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



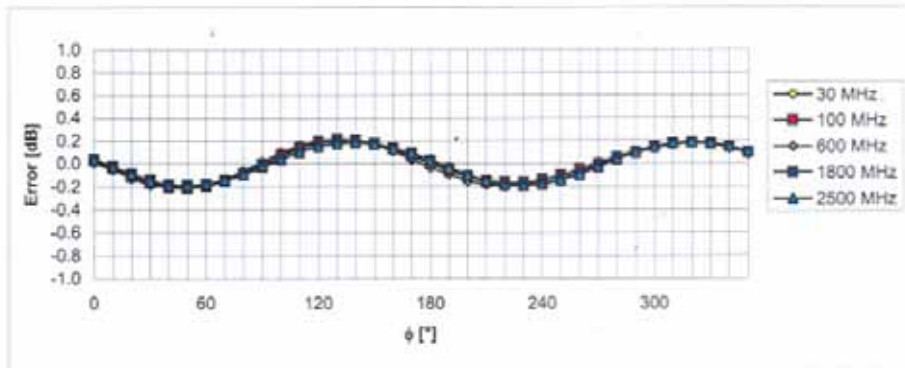
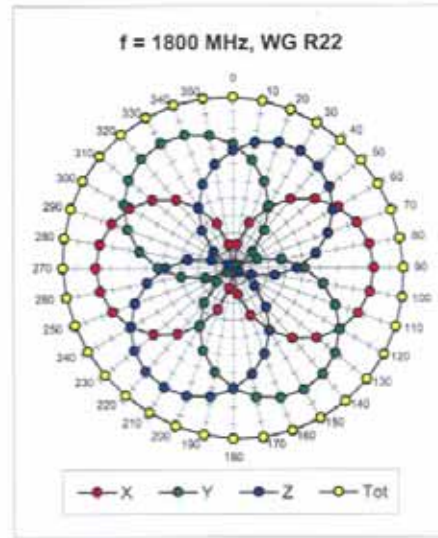
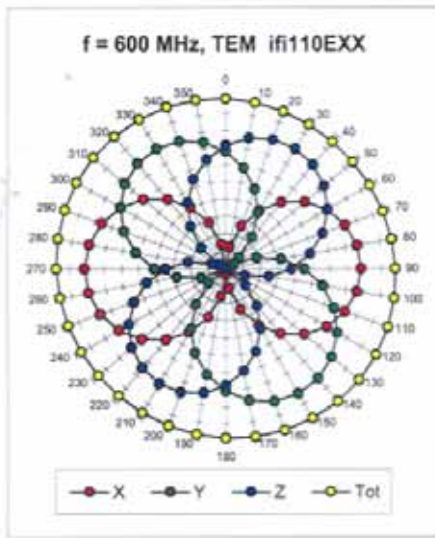
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)



ET3DV6 SN:1787

August 26, 2008

Receiving Pattern ( $\phi$ ),  $\vartheta = 0^\circ$



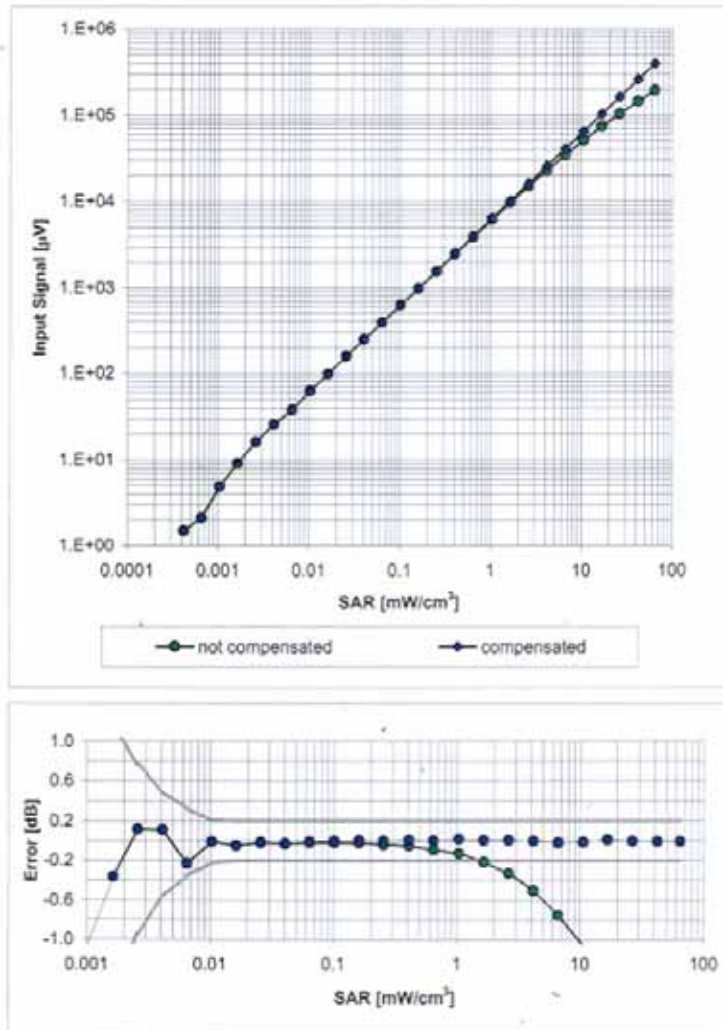
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )



ET3DV6 SN:1787

August 26, 2008

### Dynamic Range $f(\text{SAR}_{\text{head}})$ (Waveguide R22, $f = 1800 \text{ MHz}$ )

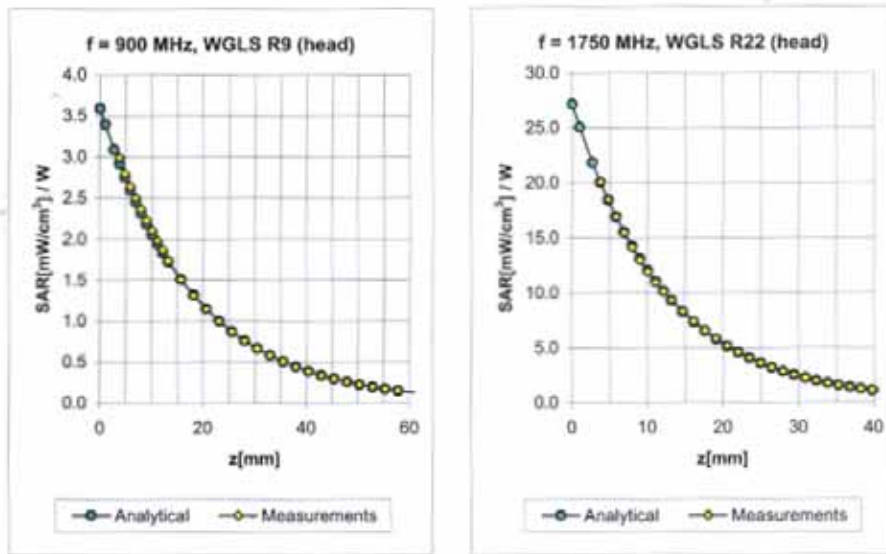


Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )

ET3DV6 SN:1787

August 26, 2008

### Conversion Factor Assessment



f [MHz]	Validity [MHz] <sup>c</sup>	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.30	2.80	6.06 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.1 ± 5%	1.37 ± 5%	0.53	2.11	5.36 ± 11.0% (k=2)
1950	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.59	1.96	5.01 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.77	1.57	4.49 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.31	2.98	5.91 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.4 ± 5%	1.49 ± 5%	0.60	2.20	4.73 ± 11.0% (k=2)
1950	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.68	1.95	4.49 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.90	1.51	3.79 ± 11.0% (k=2)

<sup>c</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

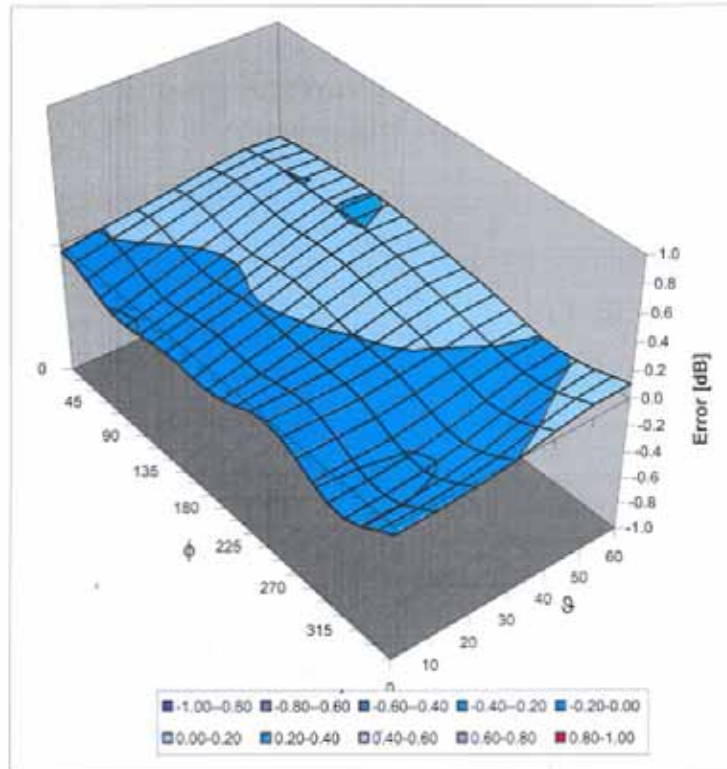


ET3DV6 SN:1787

August 26, 2008

### Deviation from Isotropy in HSL

Error ( $\phi$ ,  $\theta$ ),  $f = 900$  MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )



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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: EX3-3514\_Jan09

CALIBRATION CERTIFICATE

Object EX3DV3 - SN:3514
Calibration procedure(s) QA CAL-01.v6, QA CAL-14.v3 and QA CAL-23.v3 Calibration procedure for dosimetric E-field probes
Calibration date: January 21, 2009
Condition of the calibrated item In Tolerance

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All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Primary Standards, ID #, Cal Date (Certificate No.), Scheduled Calibration. Lists various power meters, sensors, and attenuators with their respective IDs and calibration dates.

Table with 4 columns: Secondary Standards, ID #, Check Date (in house), Scheduled Check. Lists RF generator and Network Analyzer with their IDs and check dates.

Calibrated by: Katja Pokovic, Technical Manager
Approved by: Niels Kuster, Quality Manager

Issued: January 21, 2009

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Accreditation No.: SCS 108

**Glossary:**

TSL	tissue simulating liquid
NORM <sub>x,y,z</sub>	sensitivity in free space
ConvF	sensitivity in TSL / NORM <sub>x,y,z</sub>
DCP	diode compression point
Polarization $\varphi$	$\varphi$ rotation around probe axis
Polarization $\vartheta$	$\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

**Calibration is Performed According to the Following Standards:**

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

**Methods Applied and Interpretation of Parameters:**

- *NORM<sub>x,y,z</sub>*: Assessed for E-field polarization  $\vartheta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). *NORM<sub>x,y,z</sub>* are only intermediate values, i.e., the uncertainties of *NORM<sub>x,y,z</sub>* does not effect the  $E^2$ -field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)<sub>x,y,z</sub>* = *NORM<sub>x,y,z</sub>* \* *frequency\_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCP<sub>x,y,z</sub>*: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- *ConvF and Boundary Effect Parameters*: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORM<sub>x,y,z</sub>* \* *ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- *Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.





EX3DV3 SN:3514

January 21, 2009

# Probe EX3DV3

## SN:3514

Manufactured:	December 15, 2002
Last calibrated:	January 31, 2008
Recalibrated:	January 21, 2009

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)



EX3DV3 SN:3514

January 21, 2009

DASY - Parameters of Probe: EX3DV3 SN:3514

Sensitivity in Free Space <sup>A</sup>			Diode Compression <sup>B</sup>	
NormX	0.66 ± 10.1%	μV/(V/m) <sup>2</sup>	DCP X	91 mV
NormY	0.70 ± 10.1%	μV/(V/m) <sup>2</sup>	DCP Y	94 mV
NormZ	0.60 ± 10.1%	μV/(V/m) <sup>2</sup>	DCP Z	95 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL	900 MHz	Typical SAR gradient: 5 % per mm		
	Sensor Center to Phantom Surface Distance	2.0 mm	3.0 mm	
	SAR <sub>be</sub> [%] Without Correction Algorithm	7.7	4.4	
	SAR <sub>be</sub> [%] With Correction Algorithm	0.8	0.3	

TSL	1810 MHz	Typical SAR gradient: 10 % per mm		
	Sensor Center to Phantom Surface Distance	2.0 mm	3.0 mm	
	SAR <sub>be</sub> [%] Without Correction Algorithm	6.2	3.4	
	SAR <sub>be</sub> [%] With Correction Algorithm	0.7	0.3	

Sensor Offset

Probe Tip to Sensor Center 1.0 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Page 8).

<sup>B</sup> Numerical linearization parameter; uncertainty not required.

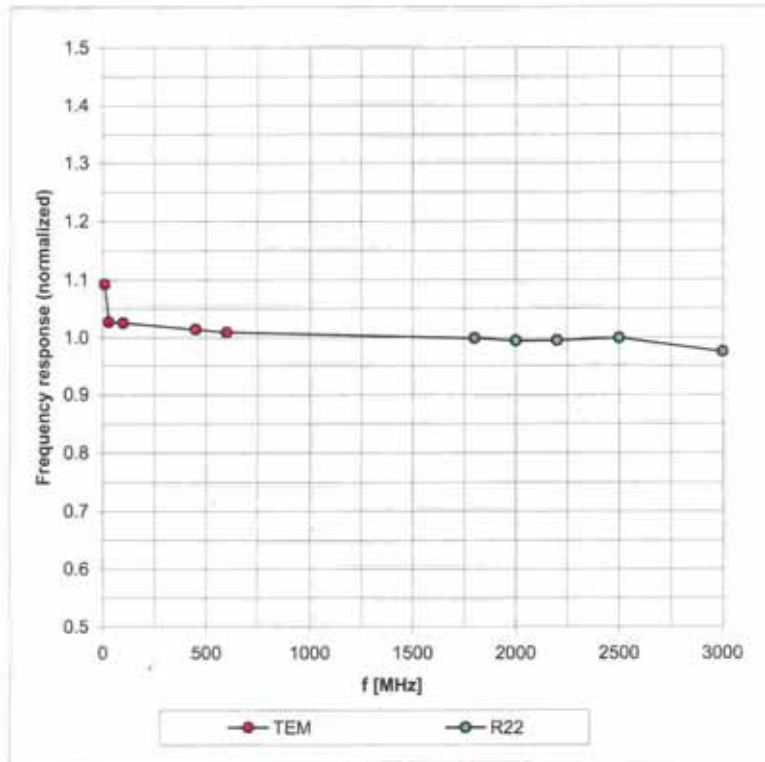


EX3DV3 SN:3514

January 21, 2009

### Frequency Response of E-Field

(TEM-Cell: ifi110 EXX, Waveguide: R22)



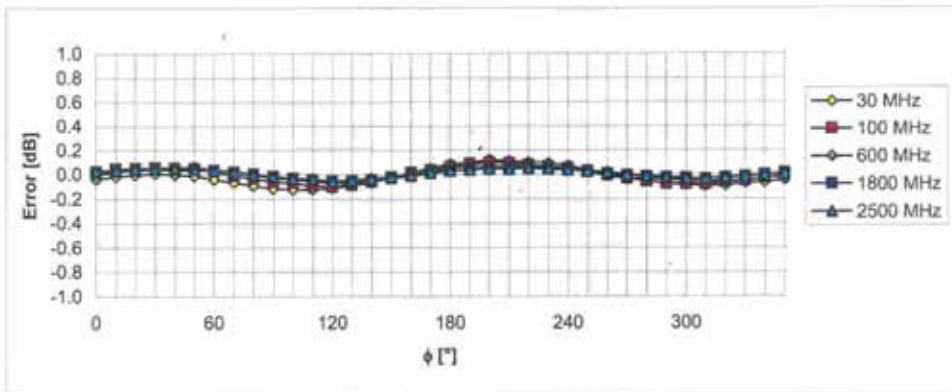
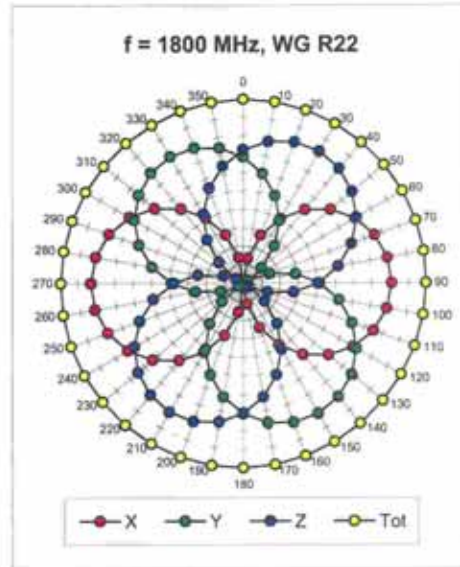
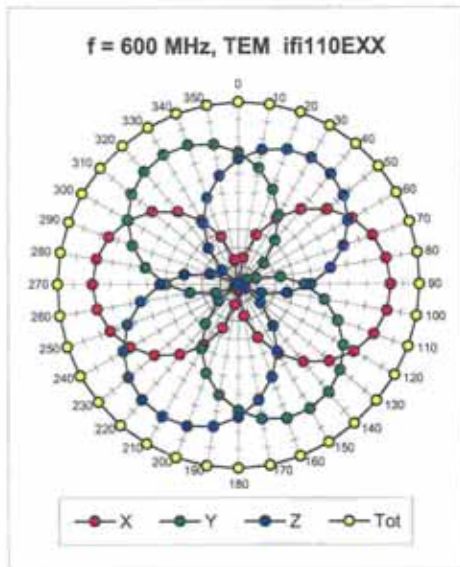
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)



EX3DV3 SN:3514

January 21, 2009

### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$



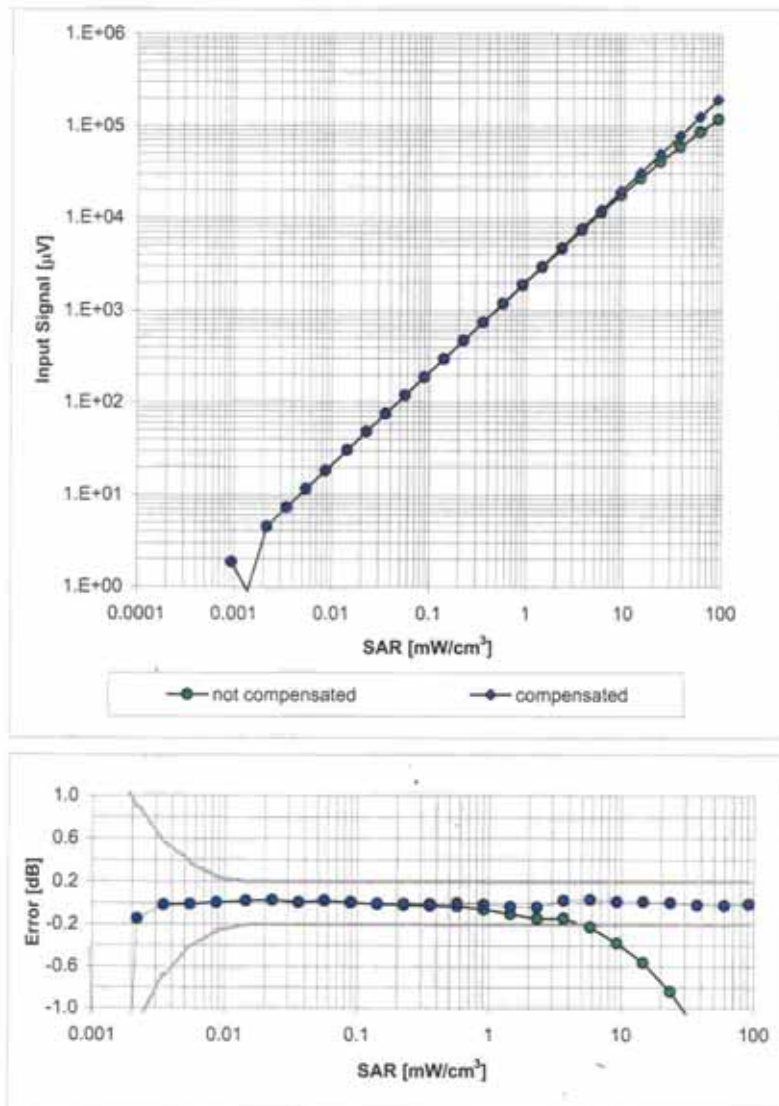
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )



EX3DV3 SN:3514

January 21, 2009

### Dynamic Range $f(SAR_{head})$ (Waveguide R22, $f = 1800$ MHz)



Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )



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### Conversion Factor Assessment

f [MHz]	Validity [MHz] <sup>c</sup>	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.45	0.76	9.31 ± 11.0% (k=2)
1810	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.60	0.63	8.16 ± 11.0% (k=2)
2300	± 50 / ± 100	Head	39.4 ± 5%	1.71 ± 5%	0.53	0.63	7.78 ± 11.0% (k=2)
2600	± 50 / ± 100	Head	39.0 ± 5%	1.96 ± 5%	0.16	2.19	7.34 ± 11.0% (k=2)
3500	± 50 / ± 100	Head	37.9 ± 5%	2.91 ± 5%	0.50	0.86	6.89 ± 13.1% (k=2)
5200	± 50 / ± 100	Head	36.0 ± 5%	4.66 ± 5%	0.40	1.70	4.78 ± 13.1% (k=2)
5300	± 50 / ± 100	Head	35.9 ± 5%	4.76 ± 5%	0.40	1.70	4.40 ± 13.1% (k=2)
5500	± 50 / ± 100	Head	35.6 ± 5%	4.96 ± 5%	0.40	1.70	4.22 ± 13.1% (k=2)
5600	± 50 / ± 100	Head	35.5 ± 5%	5.07 ± 5%	0.40	1.70	4.13 ± 13.1% (k=2)
5800	± 50 / ± 100	Head	35.3 ± 5%	5.27 ± 5%	0.40	1.70	4.13 ± 13.1% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.42	0.76	9.41 ± 11.0% (k=2)
1810	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.85	0.56	8.18 ± 11.0% (k=2)
2300	± 50 / ± 100	Body	52.8 ± 5%	1.85 ± 5%	0.18	4.17	7.60 ± 11.0% (k=2)
2600	± 50 / ± 100	Body	52.5 ± 5%	2.16 ± 5%	0.34	1.14	7.20 ± 11.0% (k=2)
3500	± 50 / ± 100	Body	51.3 ± 5%	3.31 ± 5%	0.53	0.81	6.40 ± 13.1% (k=2)
5200	± 50 / ± 100	Body	49.0 ± 5%	5.30 ± 5%	0.45	1.75	4.29 ± 13.1% (k=2)
5300	± 50 / ± 100	Body	48.9 ± 5%	5.42 ± 5%	0.45	1.75	3.94 ± 13.1% (k=2)
5500	± 50 / ± 100	Body	48.6 ± 5%	5.65 ± 5%	0.45	1.75	3.88 ± 13.1% (k=2)
5600	± 50 / ± 100	Body	48.5 ± 5%	5.77 ± 5%	0.45	1.75	3.89 ± 13.1% (k=2)
5800	± 50 / ± 100	Body	48.2 ± 5%	6.00 ± 5%	0.45	1.75	3.85 ± 13.1% (k=2)

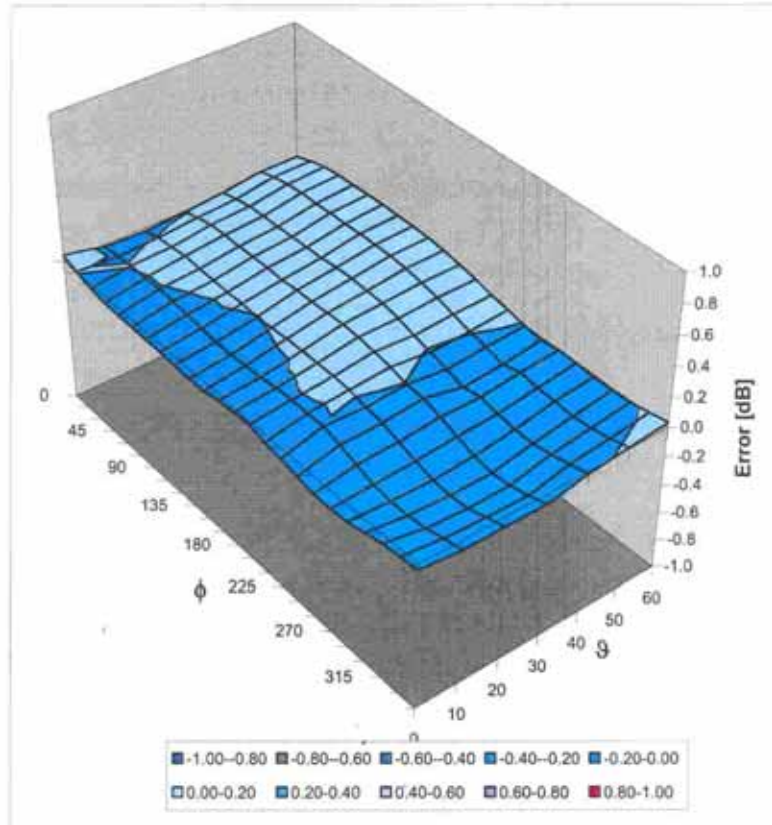
<sup>c</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



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### Deviation from Isotropy in HSL Error ( $\phi, \vartheta$ ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )